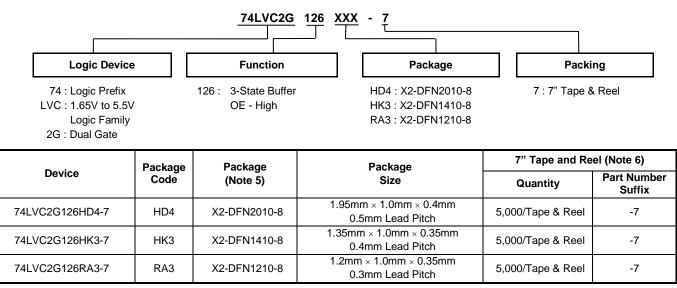


### Ordering Information (Note 4)



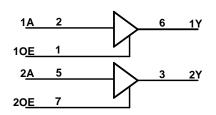
Notes: 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Pad layout as shown in Diodes Incorporated's package outline PDFs, which can be found on our website at http://www.diodes.com/package-outlines.html.
 The taping orientation is located on our website at https://www.diodes.com/assets/Packaging-Support-Docs/Ap02007.pdf.

### **Pin Descriptions**

Pin Name	Pin Number	Description
10E	1	Output Enable for buffer 1
1A	2	Data Input
2Y	3	Data Output
GND	4	Ground
2A	5	Data Input
1Y	6	Data Output
20E	7	Output Enable for buffer 2
VCC	8	Supply Voltage

### Logic Diagram



### **Function Table**

Inp	Output	
OE	Α	Y
Н	Н	Н
Н	L	L
L	Х	Z



# Absolute Maximum Ratings (Notes 7 & 8)

Symbol	Description	Rating	Unit
ESD HBM	Human Body Model ESD Protection	2	kV
ESD CDM	Charged Device Model ESD Protection	1	kV
Vcc	Supply Voltage	-0.5 to +6.5	V
VI	Input Voltage	-0.5 to +6.5	V
	Output Voltage - Active Mode	-0.5 to Vcc +0.5	V
Vo	Output Voltage Power Down Mode	-0.5 to +6.5	V
Ік	Input Clamp Current VI < 0	-50	mA
loк	Output Clamp Current ( $V_O < 0$ or $V_O > V_{CC}$ )	±50	mA
lo	Continuous Output Current (V <sub>O</sub> = 0 to V <sub>CC</sub> )	±50	mA
Icc	Continuous Current Through Vcc	100	mA
Ignd	Continuous Current Through GND	-100	mA
TJ	Operating Junction Temperature	-40 to +150	°C
Tstg	Storage Temperature	-65 to +150	°C

 Stresses beyond the absolute maximum may result in immediate failure or reduced reliability. These are stress values and device operation should be within recommend values.
 Forcing the maximum allowed voltage could cause a condition exceeding the maximum current or conversely forcing the maximum current could cause a condition exceeding the maximum voltage. The ratings of both current and voltage must be maintained within the controlled range. Notes:

# Recommended Operating Conditions (Note 9)

Symbol	Pa	arameter	Min	Мах	Unit
Vee	Operating Voltage	Operating	1.65	5.5	v
Vcc	Operating voltage	Data Retention Only	1.5	_	v
Vı	Input Voltage		0	5.5	V
Vo	Output Voltage Active Mode		0	Vcc	V
VO	Output Voltage Power-Down Mode		0	5.5	v
		V <sub>CC</sub> = 1.65V	—	-4	
		Vcc = 2.3V	—	-8	mA
Let 1	High Lovel Output Current	Vcc = 2.7V	_	-12	
lон	High-Level Output Current	Vcc = 3.0V	—	-16	
			—	-24	l
		$V_{CC} = 4.5V$	—	-32	
		Vcc = 1.65V	—	4	
		Vcc = 2.3V	—	8	
1		Vcc = 2.7V	_	12	mA
Iol	Low-Level Output Current	<u></u>	_	16	IIIA
		$V_{CC} = 3.0V$	—	24	
		Vcc = 4.5V	—	32	
A + / A > /		V <sub>CC</sub> = 1.65V to 2.7V	—	20	
Δt/ΔV	Input Transition Rise or Fall Rate	V <sub>CC</sub> = 2.7V to 5.5V	—	10	ns/V
TA	Operating Free-Air Temperature	•	-40	+125	°C

9. Unused inputs should be held at  $V_{CC}$  or Ground. Note:



# **Electrical Characteristics** (All typical values are at T<sub>A</sub> = +25°C.)

				-40	-40°C to +85°C			+125°C		
Symbol	Parameter	Test Conditions	Vcc	Min	Тур	Max	Min	Max	Unit	
			V <sub>CC</sub> = 1.65V to 1.95V	$0.65 \times V_{CC}$	_	_	$0.65 \times V_{CC}$	—		
.,	High-Level		V <sub>CC</sub> = 2.3V to 2.7V	1.7	—	_	1.7	_		
VIH	Input Voltage	_	V <sub>CC</sub> = 2.7V to 3.6V	2.0	_	—	2.0	_	V	
			$V_{CC} = 4.5V$ to 5.5V	$0.7\times V_{CC}$	—	—	$0.7\times V_{CC}$	_		
			$V_{CC} = 1.65V$ to 1.95V	_	_	$0.35 \times V_{CC}$	_	$0.35 \times V_{CC}$		
	Low-Level		$V_{CC} = 2.3 V$ to 2.7 V	—	_	0.7	_	0.7	.,	
VIL	Input Voltage	_	V <sub>CC</sub> = 2.7V to 3.6V	—	—	0.8		0.8	V	
			$V_{CC} = 4.5V$ to 5.5V	—	_	$0.3\times V_{CC}$		$0.3\times V_{CC}$		
		I <sub>OH</sub> = -100µА	1.65V to 5.5V	V <sub>CC</sub> – 0.1	Vcc	—	V <sub>CC</sub> – 0.1	—		
		Iон = -4mA	1.65V	1.2	1.53	—	0.95	—		
	High-Level	I <sub>OH</sub> = -8mA	2.3V	1.9	2.13	—	1.7	—		
Vон	Output	Iон = -12mA	2.7V	2.2	2.5	—	1.9	—	V	
	Voltage	I <sub>OH</sub> = -16mA	2)/	2.4	2.7	—	2.2	—		
		Iон = -24mA	3V	2.3	2.6	—	2.0	—		
		I <sub>OH</sub> = -32mA	4.5V	3.8	4.1		3.4	—		
		I <sub>OL</sub> = 100μΑ	1.65V to 5.5V	_	0	0.1	_	0.1		
		$I_{OL} = 4mA$	1.65V	—	0.08	0.45	_	0.7		
	Low-Level	IoL = 8mA	2.3V	—	0.14	0.3	_	0.45		
Vol	Output	$I_{OL} = 12mA$	2.7V	—	0.19	0.4	_	0.6	V	
	Voltage	I <sub>OL</sub> = 16mA	3V		0.25	0.4	_	0.6		
		$I_{OL} = 24mA$	3V	—	0.37	0.55	_	0.8		
		$I_{OL} = 32mA$	4.5V	—	0.43	0.55		0.8		
h	Input Current	VI = 5.5V or GND	0V to 5.5V	—	± 0.1	±5		± 20	μA	
l <sub>OZ</sub>	Z-State Leakage Current	$V_I = V_{IH} \text{ or } V_{IL}$ $V_O = 5.5V \text{ or } GND$	3.6V	_	± 0.1	± 10		±20	μA	
IOFF	Power Down Leakage Current	$V_I$ or $V_O = 5.5V$	0V	_	± 0.1	±10	_	±20	μA	
Icc	Supply Current	VI = 5.5V or GND Io = 0A	1.65V to 5.5V	_	0.1	10	_	40	μA	
ΔI <sub>CC</sub>	Additional Supply Current	One input at $V_{CC} - 0.6V$ Other inputs at $V_{CC}$ or GND	2.3V to 5.5V	_	5	500	_	5,000	μA	
Cı	Input Capacitance	VI = VCC or GND	3.3V	_	2.5	_	_	_	pF	



# **Operating Characteristics**

Parameter		Test Conditions	Vcc = 1.8V Typ	Vcc = 2.5V Typ	Vcc = 3.3V Typ	Vcc = 5V Typ	Unit
	Power Dissipation	f = 10MHz output enabled	17	17	17	17	pF
Cpd	Capacitance	f = 10MHz output disabled	5	5	5	5	pF

# **Package Characteristics**

Symbol	Parameter	Package	Test Conditions	Min	Тур	Max	Unit
	θ <sub>JA</sub> Thermal Resistance Junction- to-Ambient	X2-DFN2010-8			313	—	
θја		X2-DFN1410-8	(Note 10)	-	321	_	°C/W
		X2-DFN1210-8			395	—	
		X2-DFN2010-8		-	145	_	
θ <sub>JC</sub>	Thermal Resistance Junction-	X2-DFN1410-8	(Note 10)	_	166	_	°C/W
	to-Case	X2-DFN1210-8		_	236	_	

Note: 10. Test condition for each package type: Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

# **Switching Characteristics**

Typical Values at  $T_A = +25^{\circ}C$  and nominal voltages 1.8V, 2.5V, 2.7V, 3.3V, and 5.0V. See Figure 1.

Devenueter	From	То	Maa	TA =	-40°C to +8	35°C	T <sub>A</sub> = -40°C	to +125°C	11					
Parameter Input Outpu		Output	Vcc	Min	Тур	Max	Min	Max	Unit					
			1.8V ± 0.15V	1.0	3.9	9.8	1.0	12.3						
			2.5V ± 0.2V	0.5	2.6	4.9	0.5	6.3						
t <sub>pd</sub>	А	Y	2.7V	1.0	2.8	4.7	1.0	5.9	ns					
			3.3V ± 0.3V	0.5	2.4	4.4	0.5	5.4						
					5.0V ± 0.5V	0.5	1.9	3.9	0.5	4.0				
	OE Y					1.8V ± 0.15V	1.0	4.1	10.0	1.0	12.5			
			2.5V ± 0.2V	1.0	2.6	5.0	1.0	6.3						
t <sub>en</sub>		OE	OE	OE	OE	en OE	OE Y	2.7V	1.0	2.8	4.7	1.0	5.9	ns
		3.3V ± 0.3V	1.0	2.4	4.1	1.0	5.1							
			5.0V ± 0.5V	0.5	1.8	3.4	0.5	3.9						
			1.8V ± 0.15V	1.0	3.3	12.6	1.0	15.4						
			2.5V ± 0.2V	0.5	1.9	5.7	0.5	7.5						
t <sub>dis</sub>	t <sub>dis</sub> OE	Y	2.7V	1.5	3.0	4.8	1.5	6.2	ns					
			3.3V ± 0.3V	1.0	2.5	4.4	1.0	5.7						
			5.0V ± 0.5V	0.5	1.8	3.3	0.5	4.4						



Vı

0 V

VLOAD/2

Vol

Vон

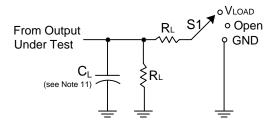
6 OV

Ум

≁

L← t<sub>PLZ</sub>

### **Parameter Measurement Information**

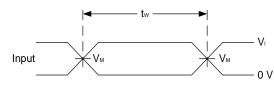


TEST (Notes 14, 15, 16)	S1
tplh/tphl	Open
tplz/tpzl	Vload
tpнz/tpzн	GND

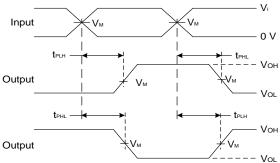
Ум

t<sub>PZL</sub> →

No.	Inp	outs	Max	Maria	C∟	<b>D</b> .	N/1
Vcc	VI	tr/tr	VМ	VM VLOAD		RL	V۵
1.8V±0.15V	Vcc	≤2ns	Vcc/2	$2 \times Vcc$	30pF	1kΩ	0.15V
2.5V±0.2V	Vcc	≤2ns	Vcc/2	$2 \times Vcc$	30pF	500Ω	0.15V
2.7V	2.7V	≤2.5ns	1.5V	6V	50pF	500Ω	0.3V
3.3V±0.3V	3V	≤2.5ns	1.5V	6V	50pF	500Ω	0.3V
5V±0.5V	Vcc	≤2.5ns	Vcc/2	$2 \times Vcc$	50pF	500Ω	0.3V



Voltage Waveform Pulse Duration (Note 13)

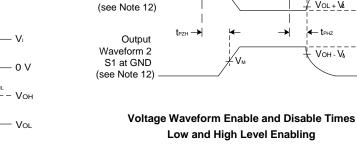


**Voltage Waveform Propagation Delay Times** Inverting and Non Inverting Outputs (Note 13)

Figure 1. Load Circuit and Voltage Waveforms

Notes:

- Includes test lead and test apparatus capacitance.
  All pulses are supplied at pulse repetition rate ≤ 10MHz.
  Inputs are measured separately one transition per measurement.
- 14.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- 15.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$ .
- 16.  $t_{\text{PLH}}$  and  $t_{\text{PHL}}$  are the same as  $t_{\text{pd.}}$



Output

Control

Output

Waveform 1

S1 at VLOAD



# **Marking Information**

### (Top View)



 $\underline{X}$  : Internal Code

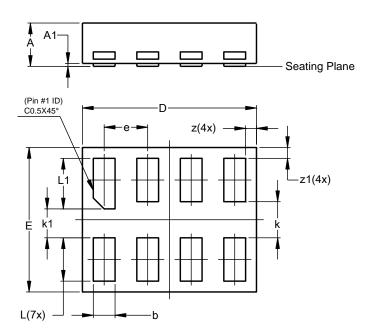
Part Number	Package	Identification Code	
74LVC2G126HD4-7	X2-DFN2010-8	9X	
74LVC2G126HK3-7	X2-DFN1410-8	9Y	
74LVC2G126RA3-7	X2-DFN1210-8	9Z	



# X2-DFN1210-8 Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

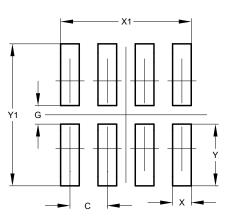
#### X2-DFN1210-8



	X2-DFN1210-8								
Dim	Dim Min Max								
Α	-	0.35	0.30						
A1	0	0.03	0.02						
b	0.10	0.20	0.15						
D	1.15	1.25	1.20						
Е	0.95	1.05	1.00						
е	-	-	0.30						
k	-	-	0.25						
k1	-	-	0.20						
L	0.25	0.35	0.30						
L1	0.30	0.40	0.35						
z	0.050	0.100	0.075						
z1	0.050	0.100	0.075						
All I	Dimens	ions in	mm						

### **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

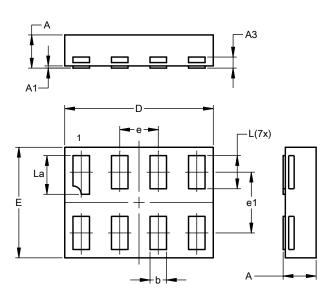


Dimensions	Value (in mm)
C	0.300
G	0.150
Х	0.150
X1	1.050
Y	0.500
Y1	1.150



# X2-DFN1410-8 Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.



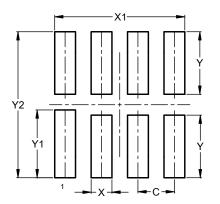
X2-DFN1410-8					
Dim	Min	Max	Тур		
Α	0.30	0.35	0.33		
A1	0.00	0.03	0.02		
A3			0.10		
b	0.12	0.20	0.15		
D	1.30	1.40	1.35		
Е	0.95	1.05	1.00		
е			0.35		
e1			0.55		
L	0.27	0.35	0.30		
L1	0.32	0.40	0.35		
All Dimensions in mm					

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

X2-DFN1410-8

X2-DFN1410-8

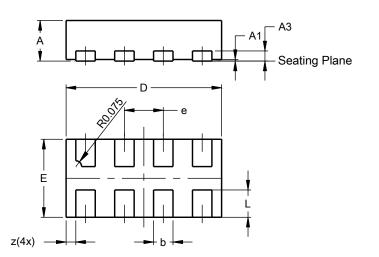


Dimensions	Value (in mm)
С	0.350
Х	0.200
X1	1.250
Y	0.600
Y1	0.650
Y2	1.400



# X2-DFN2010-8 Package Outline Dimensions

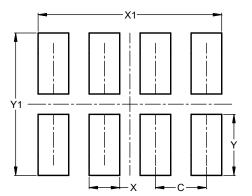
Please see http://www.diodes.com/package-outlines.html for the latest version.



X2-DFN2010-8					
Dim	Min	Max	Тур		
Α		0.40	-		
A1	0.00	0.05	0.02		
A3		-	0.13		
b	0.20	0.30	0.25		
D	1.950	2.05	2.00		
E	0.95	1.05	1.00		
е			0.50		
L	0.30	0.40	0.35		
z			0.125		
All	All Dimensions in mm				

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.



#### X2-DFN2010-8

X2-DFN2010-8

Dimensions	Value (in mm)
С	0.500
Х	0.300
X1	1.800
Y	0.600
Y1	1.400



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